

 Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,365	OSAME ET AL.	
Examiner	Art Unit	_
Long Nguyen	2816	

SEARCHED						
Class	Subclass	Date	Examiner			
327	198,217,219 218,208, 210,91, 93-95, 97,34, 72-79	3/24/05	La			
341	122,124,12					

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Enst	3/24/05	W		
		 		